

## Certificate of Analysis

Test	Specification	Result
Assay ((CH <sub>3</sub> ) <sub>2</sub> CO) (by GC, corrected for water)	≥ 99.5 %	99.8 %
Color (APHA)	≤ 10	< 5
Residue after Evaporation	≤ 5 ppm	< 5 ppm
Titration Acid (µeq/g)	≤ 0.3	< 0.1
Titration Base (µeq/g)	≤ 0.5	< 0.1
Water (H <sub>2</sub> O)	≤ 0.5 %	0.3 %
Solubility in H <sub>2</sub> O	Passes Test	Passes Test
Chloride (Cl)	≤ 0.2 ppm	< 0.1 ppm
Phosphate (PO <sub>4</sub> )	≤ 0.05 ppm	< 0.05 ppm
Trace Impurities - Aluminum (Al)	≤ 50.0 ppb	< 5.0 ppb
Arsenic and Antimony (as As)	≤ 5.0 ppb	< 5.0 ppb
Trace Impurities - Barium (Ba)	≤ 20.0 ppb	< 1.0 ppb
Trace Impurities - Beryllium (Be)	≤ 10.0 ppb	< 1.0 ppb
Trace Impurities - Bismuth (Bi)	≤ 20.0 ppb	< 10.0 ppb
Trace Impurities - Boron (B)	≤ 10.0 ppb	< 5.0 ppb
Trace Impurities - Cadmium (Cd)	≤ 10.0 ppb	< 1.0 ppb
Trace Impurities - Calcium (Ca)	≤ 25.0 ppb	< 1.0 ppb
Trace Impurities - Chromium (Cr)	≤ 10.0 ppb	< 1.0 ppb
Trace Impurities - Cobalt (Co)	≤ 10.0 ppb	< 1.0 ppb
Trace Impurities - Copper (Cu)	≤ 10.0 ppb	< 1.0 ppb
Trace Impurities - Gallium (Ga)	≤ 10.0 ppb	< 1.0 ppb
Trace Impurities - Germanium (Ge)	≤ 10.0 ppb	< 10.0 ppb
Trace Impurities - Gold (Au)	≤ 20 ppb	< 5 ppb
Trace Impurities - Iron (Fe)	≤ 20.0 ppb	< 1.0 ppb
Trace Impurities - Lead (Pb)	≤ 10.0 ppb	< 10.0 ppb
Trace Impurities - Lithium (Li)	≤ 10.0 ppb	< 1.0 ppb
Trace Impurities - Magnesium (Mg)	≤ 20 ppb	< 1 ppb
Trace Impurities - Manganese (Mn)	≤ 10.0 ppb	< 1.0 ppb

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Trace Impurities – Molybdenum (Mo)	≤ 10.0 ppb	< 5.0 ppb
Trace Impurities – Nickel (Ni)	≤ 10.0 ppb	< 5.0 ppb
Trace Impurities – Niobium (Nb)	≤ 50.0 ppb	< 1.0 ppb
Trace Impurities – Potassium (K)	≤ 10.0 ppb	< 10.0 ppb
Trace Impurities – Silicon (Si)	≤ 50 ppb	< 10 ppb
Trace Impurities – Silver (Ag)	≤ 10.0 ppb	< 1.0 ppb
Trace Impurities – Sodium (Na)	≤ 10.0 ppb	< 5.0 ppb
Trace Impurities – Strontium (Sr)	≤ 10.0 ppb	< 1.0 ppb
Trace Impurities – Tantalum (Ta)	≤ 50.0 ppb	< 5.0 ppb
Trace Impurities – Thallium (Tl)	≤ 10.0 ppb	< 5.0 ppb
Trace Impurities – Tin (Sn)	≤ 20.0 ppb	< 10.0 ppb
Trace Impurities – Titanium (Ti)	≤ 10.0 ppb	< 1.0 ppb
Trace Impurities – Vanadium (V)	≤ 10.0 ppb	< 1.0 ppb
Trace Impurities – Zinc (Zn)	≤ 20.0 ppb	< 1.0 ppb
Trace Impurities – Zirconium (Zr)	≤ 10.0 ppb	< 1.0 ppb
Particle Count – 0.5 µm and greater (Rion KS42AF)	≤ 100 par/ml	1 par/ml
Particle Count – 1.0 µm and greater (Rion KS42AF)	≤ 8 par/ml	1 par/ml

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Acetone  
CMOS



Material No.: 9005-68  
Batch No.: 23H3161083

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For Microelectronic Use

Country of Origin: USA  
Packaging Site: Paris Mfg Ctr & DC

Michelle Bales  
Sr. Manager, Quality Assurance

For questions on this Certificate of Analysis please contact Technical Services at 855.282.6867 or +1.610.386.1700  
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